



# Gallium Nitride 50V, 750W, 2.3-2.4GHz RF Power Transistor

## Description

The XTAV24750B4VC is a 750-watt, internally matched GaN HEMT, designed for 5G cellular applications with frequencies from 2.3-2.4GHz, **enabled by wide band VBW capability to support IBW up to 100MHz.**

It can be configured as asymmetrical Doherty for 4G or 5G application, delivering 100W average power, according to normal 8.5dB back off.

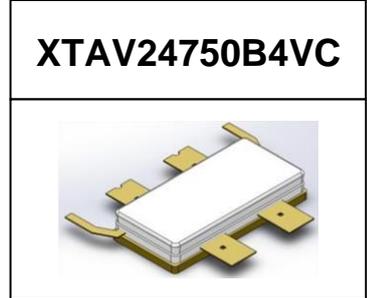
There is no guarantee of performance when this part is used in applications designed Outside of these frequencies.

- Typical Doherty Pulsed CW and 1C W--CDMA Characterization Performance:

$V_{DD} = 50 \text{ Vdc}$ ,  $I_{DQA} = 270 \text{ mA}$ ,  $V_{GSB} = -4.5\text{Vdc}$ ,

(1) Pulsed condition: 20us and 10%

(2) 1C WCDMA; Signal PAR = 10 dB @ 0.01% Probability on CCDF.



Freq (GHz)	Pulse CW Signal <sup>(1)</sup>			$P_{avg}=50.0\text{dBm}$ WCDMA Signal <sup>(2)</sup>		
	P3 (dBm)	P4 (dBm)	P4 (W)	Gp (dB)	$\eta_D$ (%)	ACPR <sub>5M</sub> (dBc)
2.30	58.50	59.01	796	13.80	53.60	-28.80
2.35	59.10	59.20	831	14.13	53.70	-29.88
2.40	59.01	59.03	800	14.50	53.10	-30.08

Recommended driver: Doherty (1 stage discrete solution): STAV27070C6

## Applications

- Asymmetrical Doherty amplifier within B40 4G band
- S band power amplifier

## Important Note: Proper Biasing Sequence for GaN HEMT Transistors

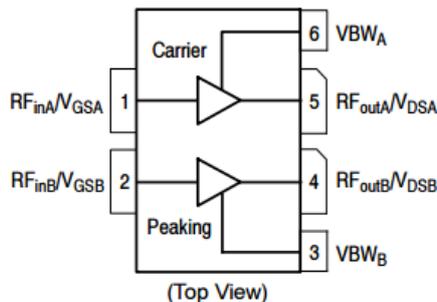
### Turning the device ON

1. Set VGS to the pinch-off (VP) voltage, typically -5 V
2. Turn on VDS to nominal supply voltage
3. Increase VGS until IDS current is attained
4. Apply RF input power to desired level

### Turning the device OFF

1. Turn RF power off
2. Reduce VGS down to VP, typically -5 V
3. Reduce VDS down to 0 V
4. Turn off VGS

## 1: Pin Connection definition





**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain—Source Voltage	$V_{DSS}$	+200	Vdc
Gate—Source Voltage	$V_{GS}$	-8 to +0.5	Vdc
Operating Voltage	$V_{DD}$	55	Vdc
Maximum gate current	$I_{gs}$	92	mA
Storage Temperature Range	$T_{stg}$	-65 to +150	°C
Case Operating Temperature	$T_c$	+150	°C
Operating Junction Temperature	$T_j$	+225	°C

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case by FEA $T_c = 85^\circ\text{C}$ , $P_{out} = 100\text{W}$ , 2.6GHz Doherty application board	$R_{\theta JC}$	0.9	°C /W

**Table 3. Electrical Characteristics (TA = 25°C unless otherwise noted)**

**DC Characteristics (main path, measured on wafer prior to packaging)**

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS} = -8\text{V}$ ; $I_{DS} = 38\text{mA}$	$V_{DSS}$		200		V
Gate Threshold Voltage	$V_{DS} = 10\text{V}$ , $I_D = 38\text{mA}$	$V_{GS(th)}$	-4		-2	V
Gate Quiescent Voltage	$V_{DS} = 50\text{V}$ , $I_{DS} = 280\text{mA}$ , Measured in Functional Test	$V_{GS(Q)}$		-2.7		V

**DC Characteristics (peak path, measured on wafer prior to packaging)**

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS} = -8\text{V}$ ; $I_{DS} = 70\text{mA}$	$V_{DSS}$		200		V
Gate Threshold Voltage	$V_{DS} = 10\text{V}$ , $I_D = 70\text{mA}$	$V_{GS(th)}$	-4		-2	V
Gate Quiescent Voltage	$V_{DS} = 50\text{V}$ , $I_{DS} = 500\text{mA}$ Measured in Functional Test	$V_{GS(Q)}$		-2.7		V

**Ruggedness Characteristics**

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Load mismatch capability	2.4GHz, $P_{out} = 100\text{W}$ WCDMA 1 Carrier in Doherty circuit All phase, No device damages	VSWR		10:1		



Figure 3: Efficiency and power gain as function of Pout

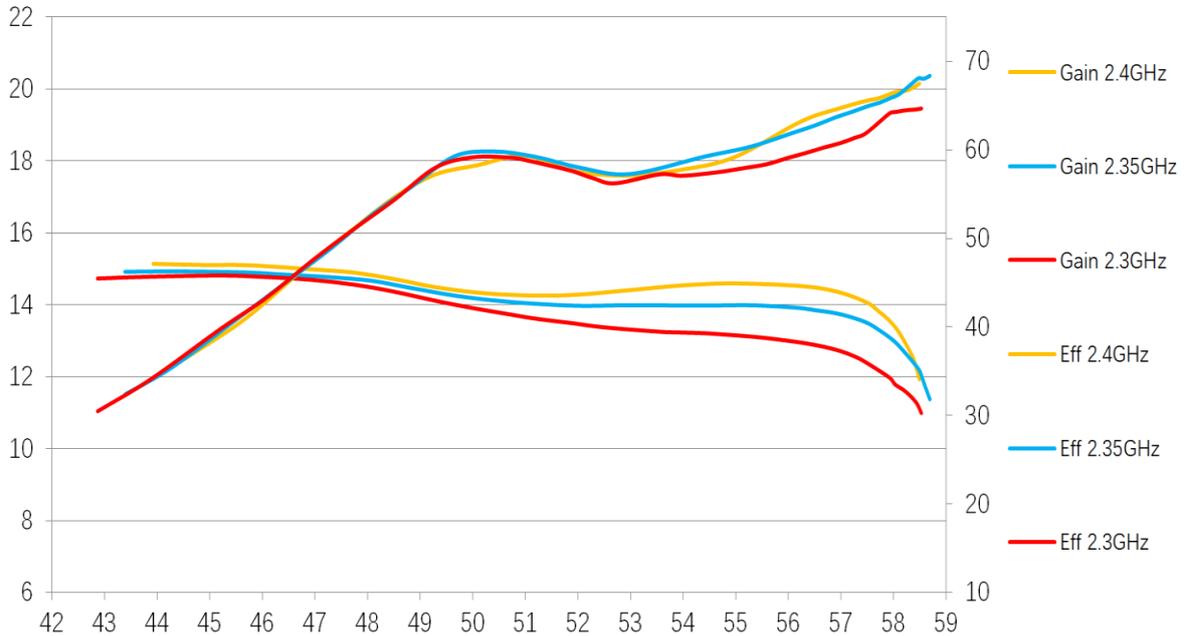
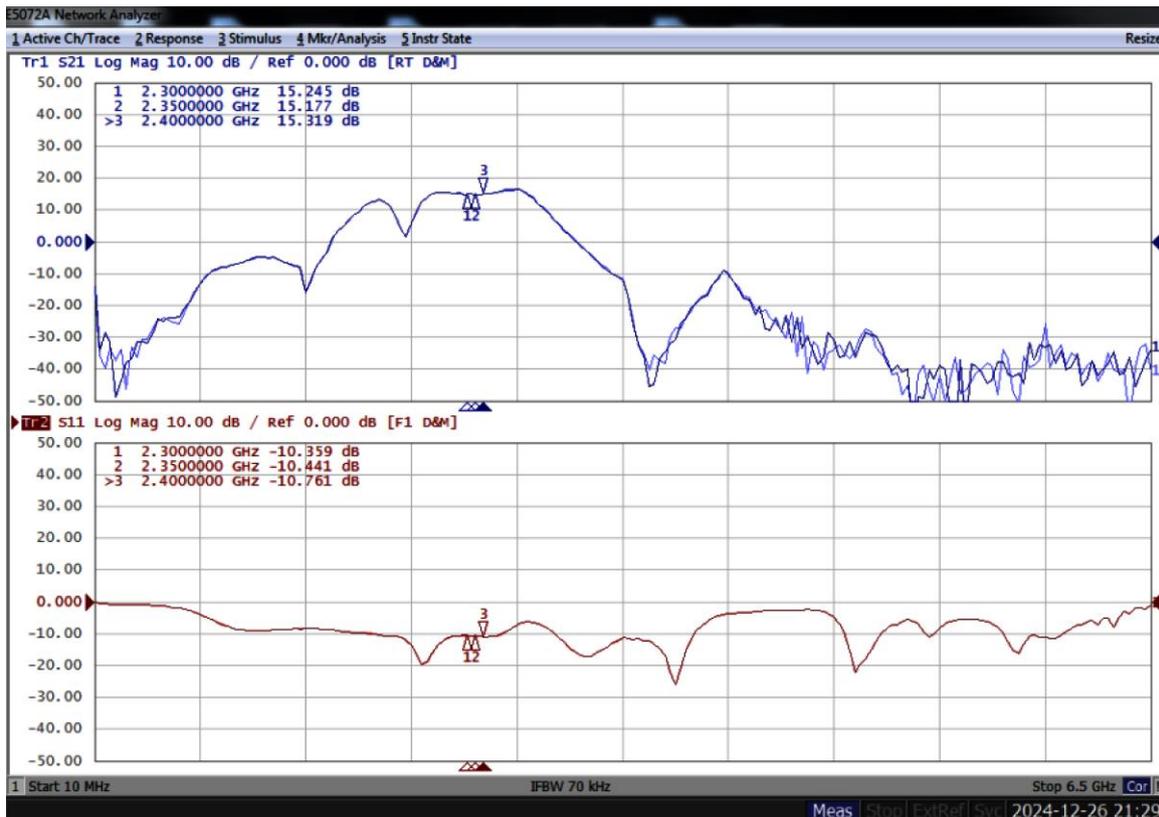
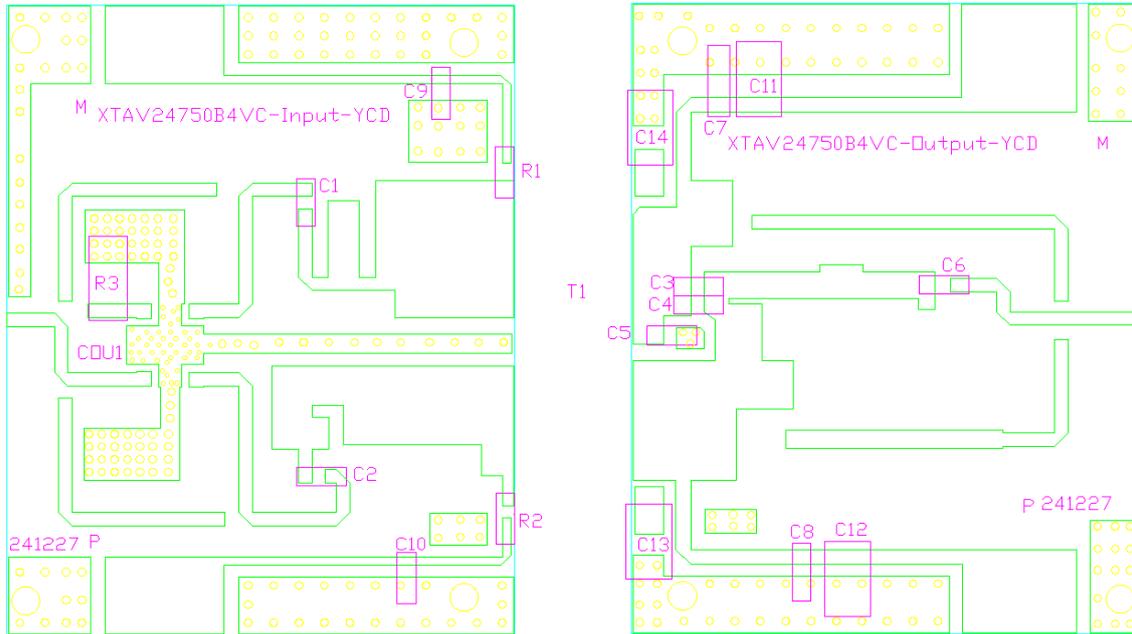


Figure 4: Network analyzer output, S11 and S21



**Figure 5: Picture of application board Doherty circuit**

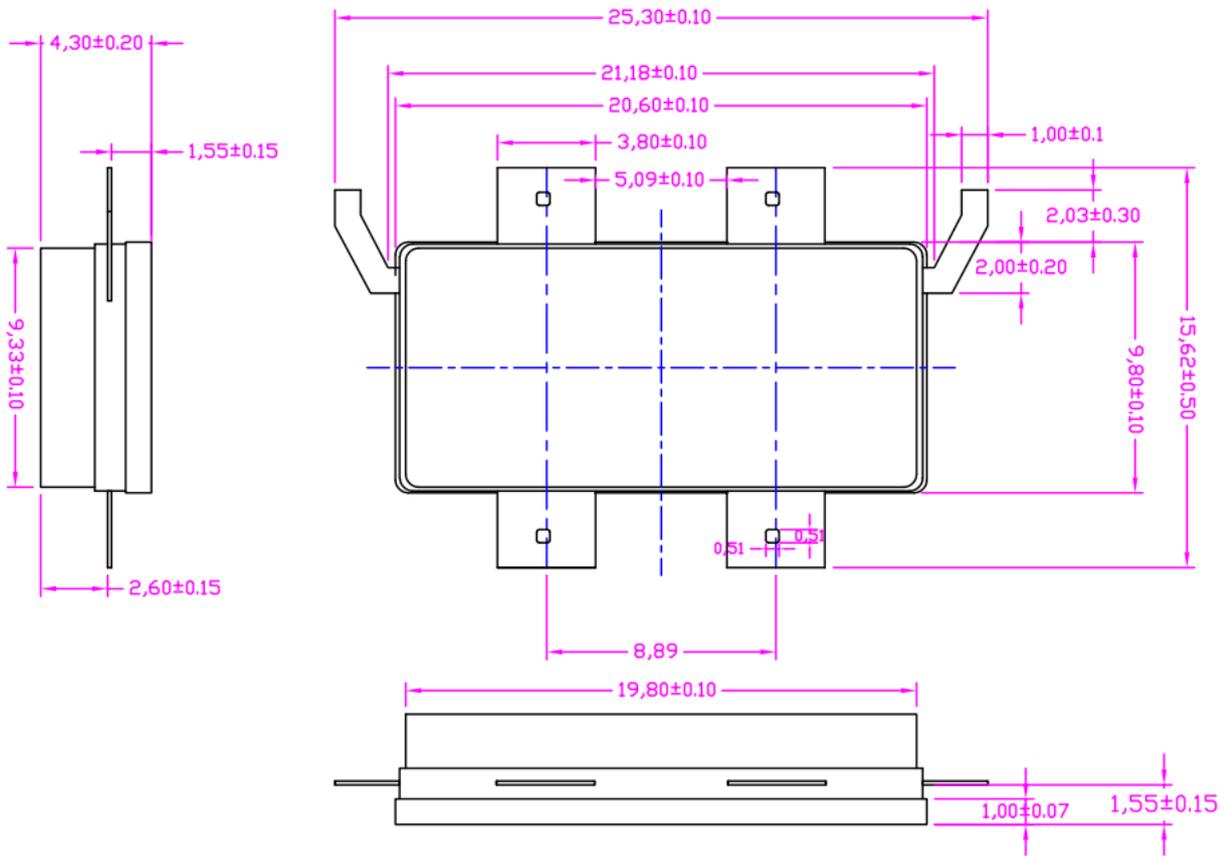


**Table 4. Bill of materials of application board (PCB layout upon request, RO4350B 20mils)**

Part	Quantity	Description	Part Number	Manufacture
C1,C2,C6,C7,C8,C9,C10	7	10pF High Q Capacitor	251SHS100BSE	TEMEX
C3,C4	2	2.2pF High Q Capacitor	251SHS2R2BSE	TEMEX
C5	1	1.8pF High Q Capacitor	251SHS1R8BSE	TEMEX
C11,C12,C13,C14	4	10uF MLCC	GRM32EC72A10	Murata
R1,R2	2	10 Ω Power Resistor	ESR03EZPF100	ROHM
R3	1	51 Ω Power Resistor	2512	RN2
COU1	1	3 dB Bridge	X3C26P1-03S	Anaren
T1	1	750W GaN Dual Transistor	XTAV24750B4VC	Innogrations



Earless Flanged Ceramic Package; 6 leads- B4VC



Revision history

Table 4. Document revision history

Date	Revision	Datasheet Status
2024/12/27	V1.0	Advanced Datasheet Creation

Application data based on LWH-24-48

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